

### Features

- Operate from 1.65V to 5.5V
- Inputs Accept Voltages to 5.5V
- High Noise Immunity
- Low Power Dissipation
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)
- SOT23-5 Package Available
- SOT353 Package Available
- SOT553 Package Available

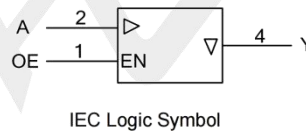
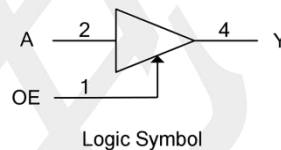
### General Description

The **TP74V1G126** is a single bus buffer/line driver with 3-state output. When the output enable (OE) is high the output will be disabled. In contrast, when the OE is low, true data will pass from A input to the Y output. This device has power-down protective circuit to prevent the device from destruction when it is powered down.

### Applications

- AV Receiver
- Audio Dock:Portable
- Blu-ray Player and Home Theater
- Embedded PC
- Personal Digital Assistant(PDA)
- Power:Telecom/Server AC/DC Supply:Single Controller:Analog and Digital
- Solid State Drive(SSD):Client and Enterprise
- TV:LCD/Digital and High-Definition(HDTV)
- Tablet:Enterprise
- Video Analytics:Server

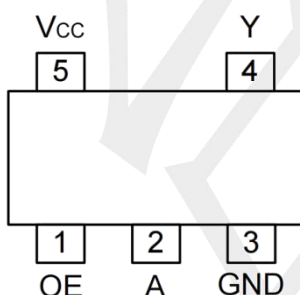
### Logic Diagram



### Ordering Information

ORDER NUMBER	PACKAGE DESCRIPTION	PACKAGE OPTION	Marking
TP74LVC1G126S5	SOT23-5	Tape and Reel,3000	S126
TP74LVC1G126C5	SOT353	Tape and Reel,3000	C126
TP74LVC1G126C7	SOT553	Tape and Reel,3000	CN7

### Pin Configuratio



### Function Table

INPUT(OE)	INPUT(A)	OUTPUT(Y)
H	L	L
H	H	H
L	X	Z

Note: H: HIGH voltage level; L: LOW voltage level; X=don't care; Z=high-impedance OFF-state.

SOT23-5 / SOT353 / SOT553

## Absolute Maximum Ratings

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	VCC		-0.5 ~ +6.5	V
Input Voltage	VIN		-0.5 ~ +6.5	V
Output Voltage	VOUT	Enable mode	-0.5 ~ VCC + 0.5	V
		Disable mode	-0.5 ~ +6.5	V
		Power-down mode	-0.5 ~ +6.5	V
VCC or GND Current	ICC	Output in the Power-off state	±100	mA
Continuous Output Current	IOUT	VOUT=0~VCC	±50	mA
Input Clamp Current	I <sub>IK</sub>	VIN<0	-50	mA
Output Clamp Current	I <sub>OK</sub>	VOUT<0	-50	mA
Storage Temperature Range	TSTG		-65 ~ +150	°C
Junction to Ambient	$\theta_{Jc}$	SOT-23-5	280	°C/W
		SOT353	350	°C/W
		SOT553	480	°C/W

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

## Recommended Operating Conditions

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	VCC	Operating	1.65	--	5.5	V
Input Voltage	VIN		0	--	5.5	V
Output Voltage	VOUT	VCC=1.65V ~ 5.5V; Enable mode	0	--	VCC	V
		VCC=1.65V ~ 5.5V; Disable mode	0	--	5.5	V
		VCC=0V; Power-down mode	0	--	5.5	V
Input Transition Rise or Fall Rate	t <sub>R</sub> /t <sub>F</sub>	VCC=1.65V ~ 2.7V	--	--	20	ns/V
		VCC=2.7V ~ 5.5V	--	--	10	ns/V
Operating Temperature	TA		-40	--	125	°C

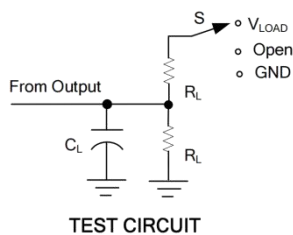
**Electrical Characteristics** (unless otherwise specified)

PARAMETER	SYMBOL	TEST Conditions	TA=25°C			TA=-40°C~+125°C			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
High-Level Input Voltage	V <sub>IH</sub>	V <sub>CC</sub> =1.65V ~ 1.95V	0.65×V <sub>CC</sub>	--	--	0.65×V <sub>CC</sub>	--	--	V
		V <sub>CC</sub> =2.3V ~ 2.7V	1.7	--	--	1.7	--	--	V
		V <sub>CC</sub> =3V ~ 3.6V	2	--	--	2	--	--	V
		V <sub>CC</sub> =4.5V ~ 5.5V	0.7×V <sub>CC</sub>	--	--	0.7×V <sub>CC</sub>	--	--	V
Low-Level Input Voltage	V <sub>IL</sub>	V <sub>CC</sub> =1.65V ~ 1.95V	--	--	0.35×V <sub>CC</sub>	--	--	0.35×V <sub>CC</sub>	V
		V <sub>CC</sub> =2.3V ~ 2.7V	--	--	0.7	--	--	0.7	V
		V <sub>CC</sub> =3V ~ 3.6V	--	--	0.8	--	--	0.8	V
		V <sub>CC</sub> =4.5V ~ 5.5V	--	--	0.35×V <sub>CC</sub>	--	--	0.35×V <sub>CC</sub>	V
High-Level Output Voltage	V <sub>OH</sub>	V <sub>CC</sub> =1.65 ~ 5.5V, I <sub>OH</sub> =-100μA	V <sub>CC</sub> -0.1	--	--	V <sub>CC</sub> -0.1	--	--	V
		V <sub>CC</sub> =1.65V, I <sub>OH</sub> =-4mA	1.2	--	--	0.95	--	--	V
		V <sub>CC</sub> =2.3V, I <sub>OH</sub> =-8mA	1.9	--	--	1.7	--	--	V
		V <sub>CC</sub> =2.7V, I <sub>OH</sub> =-12mA	2.2	--	--	1.9	--	--	V
		V <sub>CC</sub> =3.0V, I <sub>OH</sub> =-24mA	2.3	--	--	2	--	--	V
		V <sub>CC</sub> =4.5V, I <sub>OH</sub> =-32mA	3.8	--	--	3.4	--	--	V
Low-Level Output Voltage	V <sub>OL</sub>	V <sub>CC</sub> =1.65 ~ 5.5V, I <sub>OL</sub> =100μA	--	--	0.1	--	--	0.1	V
		V <sub>CC</sub> =1.65V, I <sub>OL</sub> =4mA	--	--	0.45	--	--	0.7	V
		V <sub>CC</sub> =2.3V, I <sub>OL</sub> =8mA	--	--	0.3	--	--	0.45	V
		V <sub>CC</sub> =3.0V, I <sub>OL</sub> =-16mA	--	--	0.4	--	--	0.6	V
		V <sub>CC</sub> =3.0V, I <sub>OL</sub> =-24mA	--	--	0.55	--	--	0.8	V
		V <sub>CC</sub> =4.5V, I <sub>OL</sub> =-32mA	--	--	0.55	--	--	0.8	V
Input Leakage Current	I <sub>I(LEAK)</sub>	V <sub>CC</sub> =0 ~ 5.5V, V <sub>IN</sub> =5.5V or GND	--	±0.1	±5	--	--	±5	uA
Power OFF Leakage Current	I <sub>OFF</sub>	V <sub>CC</sub> =0V, V <sub>IN</sub> or V <sub>OUT</sub> =5.5V	--	±0.1	±10	--	--	±10	uA
Quiescent Supply Current	I <sub>Q</sub>	V <sub>CC</sub> =1.65 ~ 5.5V, V <sub>IN</sub> =V <sub>CC</sub> or GND, I <sub>OUT</sub> =0A	--	±0.1	10	--	--	±10	uA
Additional Quiescent Supply Current Per Input Pin	ΔI <sub>Q</sub>	V <sub>CC</sub> =3 ~ 5.5V, One input at V <sub>CC</sub> -0.6V, Other inputs at V <sub>CC</sub> or GND	--	5	500	--	--	500	uA

### SWITCHING CHARACTERISTICS ( unless otherwise specified)

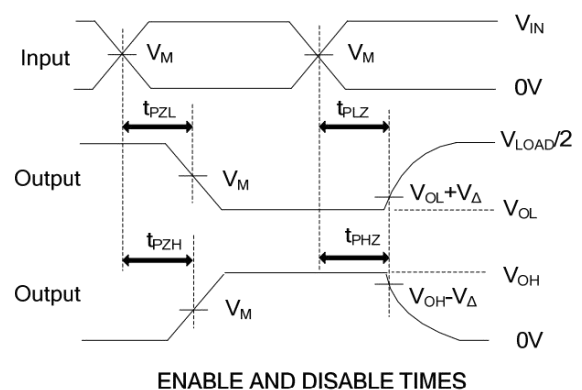
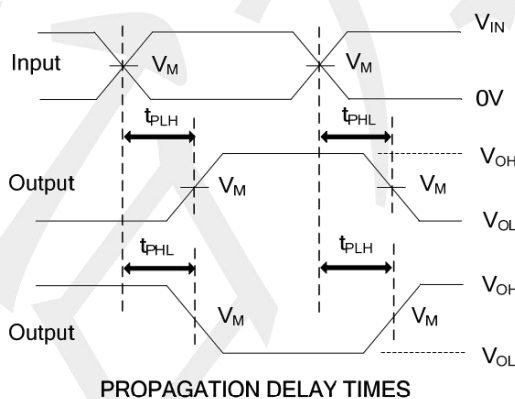
PARAMETER	SYMBOL	TEST Conditions		TA=25°C			TA=-40°C~+125°C			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
Propagation Delay From Input A to Output Y	t <sub>PLH</sub> / t <sub>PHL</sub>	CL=30pF	V <sub>CC</sub> =1.8±0.15V, R <sub>L</sub> =1KΩ	1	--	16	--	--	20	nS
			V <sub>CC</sub> =2.5±0.2V, R <sub>L</sub> =500Ω	0.5	--	10	--	--	14	nS
		CL=50pF R <sub>L</sub> =500Ω	V <sub>CC</sub> =2.7V	0.5	--	10	--	--	14	nS
			V <sub>CC</sub> =3.3±0.3V	0.5	--	7	--	--	11	nS
3-State Output Enable Time From Input OE to Output Y	t <sub>PZH</sub> / t <sub>PZL</sub>	CL=30pF	V <sub>CC</sub> =1.8±0.15V, R <sub>L</sub> =1KΩ	1	--	18	--	--	22	nS
			V <sub>CC</sub> =2.5±0.2V, R <sub>L</sub> =500Ω	0.5	--	11	--	--	14	nS
		CL=50pF R <sub>L</sub> =500Ω	V <sub>CC</sub> =2.7V	0.5	--	11	--	--	14	nS
			V <sub>CC</sub> =3.3±0.3V	0.5	--	7	--	--	11	nS
3-State Output Disable Time From Input OE to Output Y	t <sub>PLZ</sub> / t <sub>PHZ</sub>	CL=30pF	V <sub>CC</sub> =1.8±0.15V, R <sub>L</sub> =1KΩ	1	--	10	--	--	13	nS
			V <sub>CC</sub> =2.5±0.2V, R <sub>L</sub> =500Ω	0.5	--	8	--	--	10	nS
		CL=50pF R <sub>L</sub> =500Ω	V <sub>CC</sub> =2.7V	0.5	--	7	--	--	9	nS
			V <sub>CC</sub> =3.3±0.3V	0.5	--	6	--	--	8	nS
			V <sub>CC</sub> =5±0.5V	0.5	--	5	--	--	7	nS

### TEST CIRCUIT AND WAVEFORMS



TEST	S
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>

V <sub>CC</sub>	INPUTS		V <sub>M</sub>	V <sub>LOAD</sub>	V <sub>Δ</sub>	C <sub>L</sub>	R <sub>L</sub>
	V <sub>IN</sub>	t <sub>r</sub> , t <sub>f</sub>					
1.8V±0.15V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	2 x V <sub>CC</sub>	0.15V	30pF	1KΩ
2.5V±0.2V	V <sub>CC</sub>	≤2ns	V <sub>CC</sub> /2	2 x V <sub>CC</sub>	0.15V	30pF	500Ω
2.7V	2.7V	≤2.5ns	1.5V	6V	0.3V	50pF	500Ω
3.3V±0.3V	2.7V	≤2.5ns	1.5V	6V	0.3V	50pF	500Ω
5V±0.5V	V <sub>CC</sub>	≤2.5ns	V <sub>CC</sub> /2	2 x V <sub>CC</sub>	0.3V	50pF	500Ω

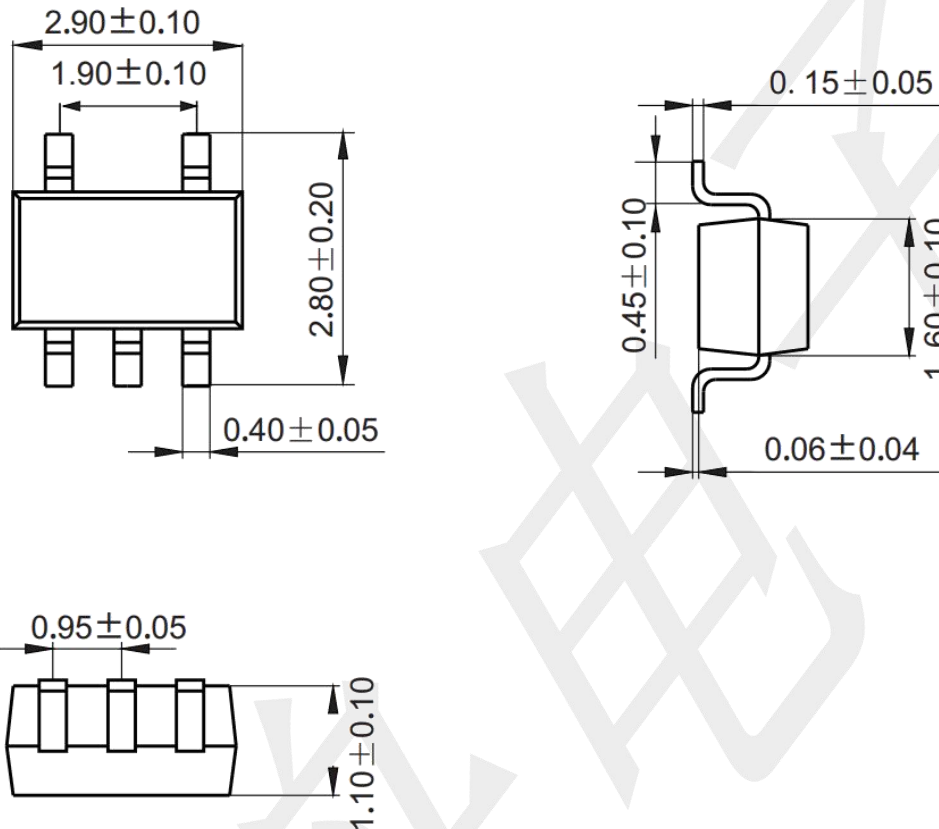


Notes: 1. C<sub>L</sub> includes probe and jig capacitance.

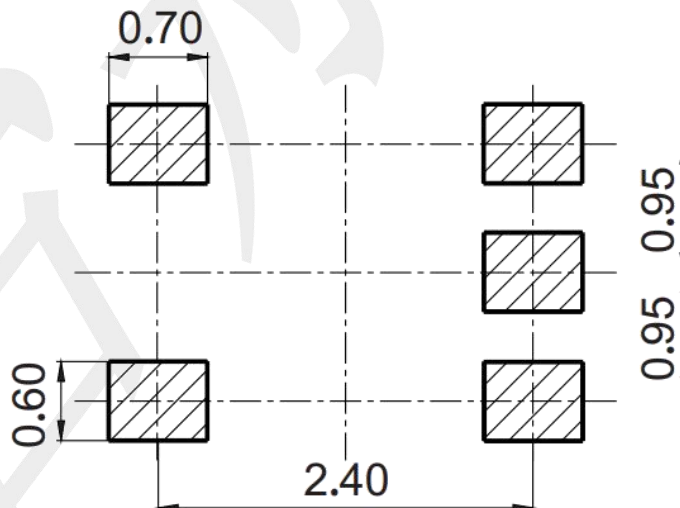
2. All input pulses are supplied by generators having the following characteristics: P<sub>RR</sub> ≤ 10MHz, Z<sub>O</sub> = 50Ω.

**Package information (Unit: mm)**

SOT23-5

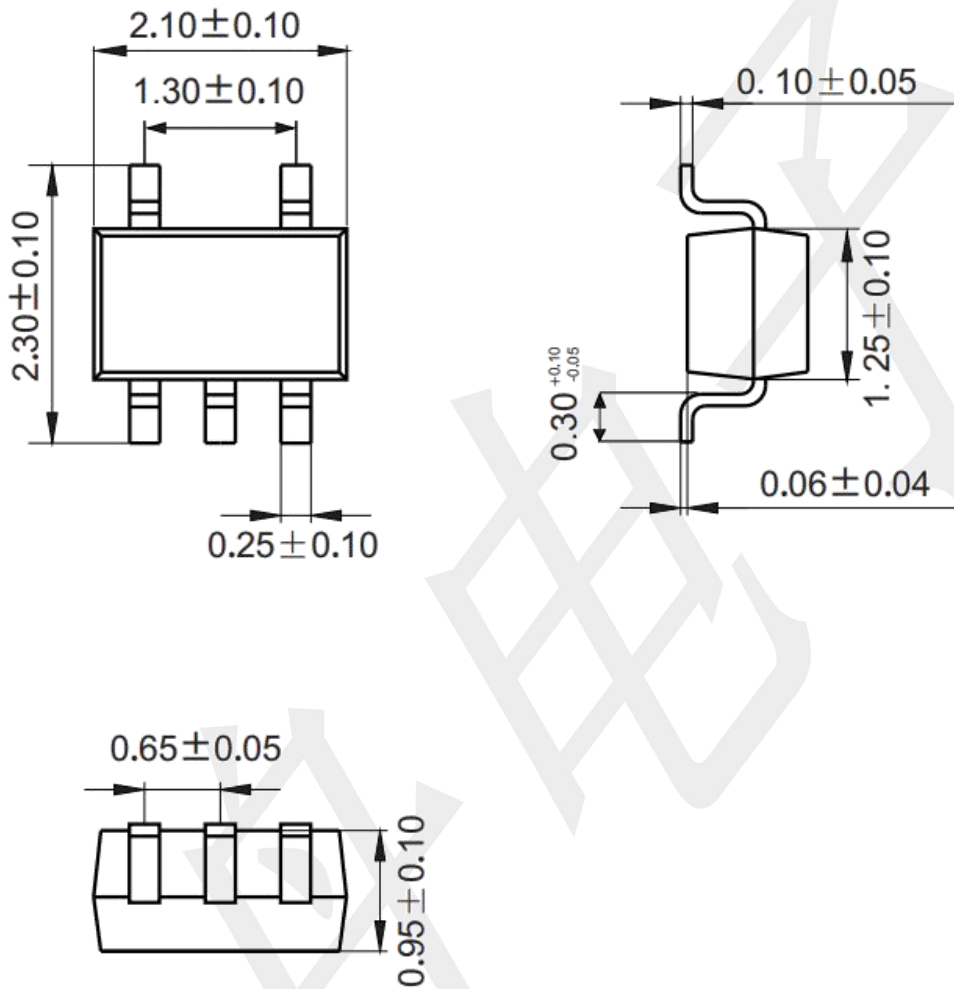


**Mounting Pad Layout (Unit: mm)**

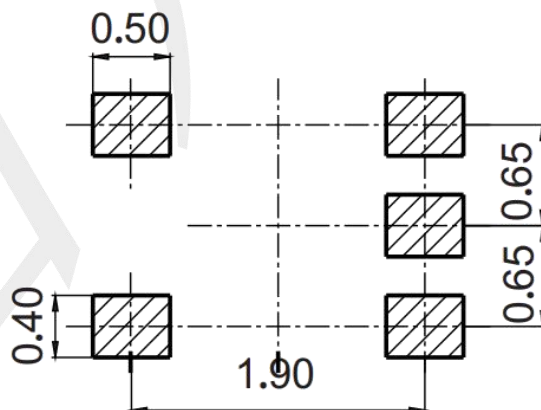


**Package information (Unit: mm)**

SOT353

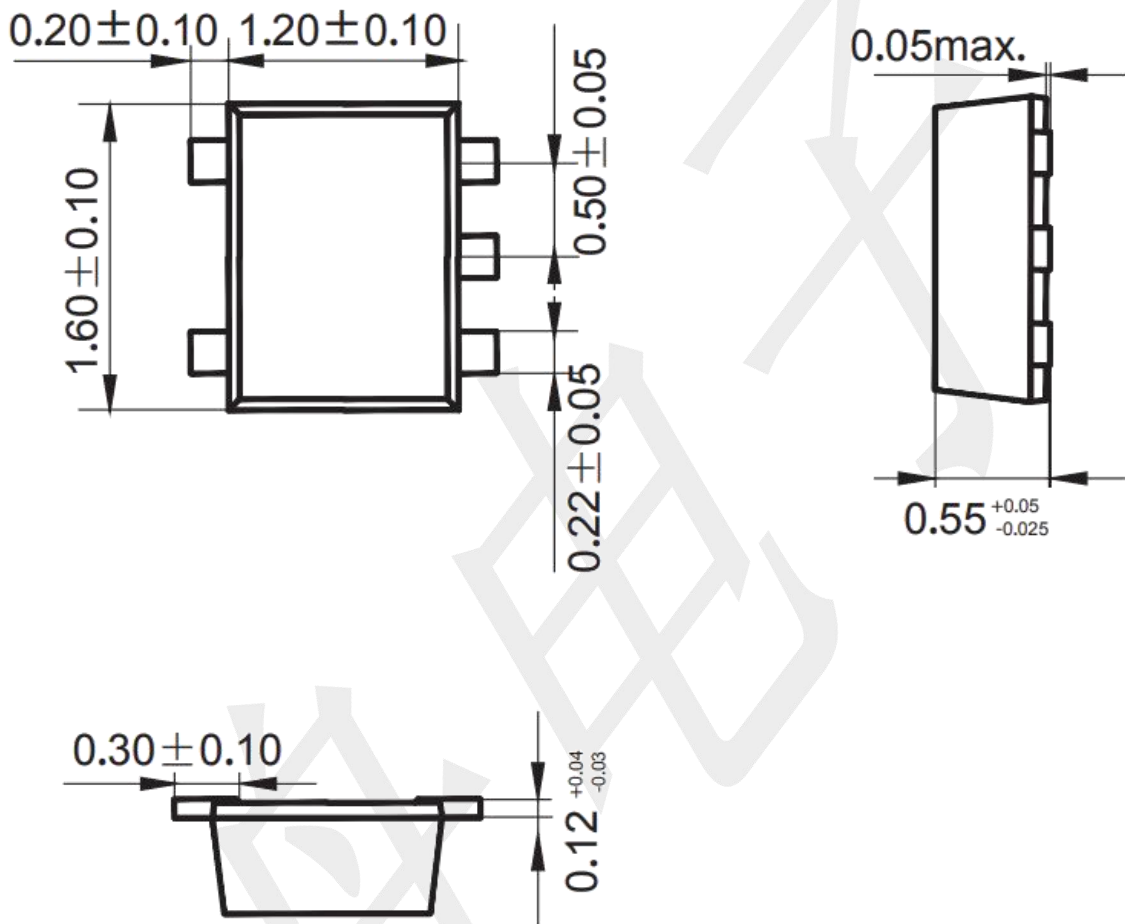


**Mounting Pad Layout (Unit: mm)**



**Package information (Unit: mm)**

SOT553



**Mounting Pad Layout (Unit: mm)**

